

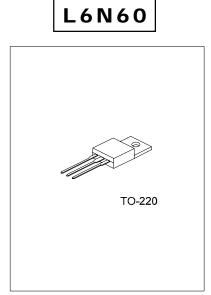
6.2 Amps, 600/650 Volts N-CHANNEL MOSFET

DESCRIPTION

The LRC L6N60 is a high voltage MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in switching power supplies and adaptors.

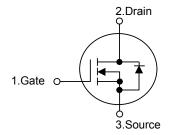
FEATURES

- * $R_{DS(ON)}$ = 1.5 Ω @V_{GS} = 10V
- * Ultra low gate charge (typical 20 nC)
- * Low reverse transfer Capacitance (C_{RSS} = typical 10pF)
- * Fast switching capability
- * Avalanche energy tested
- * Improved dv/dt capability, high ruggedness



SYMBOL

*Pb-free plating product number: L6N60L



ORDERING INFORMATION

Ordering Number		Paakaga	Pin Assignment			Docking	
Normal	Lead Free Plating	Package	1	2	3	Packing	
L6N60-x-TA3-T	L6N60L-x-TA3-T	TO-220	G	D	S	Tube	

L6N60L-x-TA3-T (1)Packing Type (2)Package Type (3)Drain-Source Voltag (4)Lead Plating	 (1) T: Tube, R: Tape Reel (2) TA3: TO-220 (3) A: 600V, B: 650V (4) L: Lead Free Plating, Blank: Pb/Sn
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L6N60

TER	SYMBOL	RATINGS	UNIT
6N60-A	N/	600	V
6N60-B	VDSS	650	V
	V _{GSS}	±30	V
	I _{AR}	6.2	А
T _C = 25°C		6.2	А
T _C = 100°C	ID	3.9	А
Pulsed Drain Current (Note 1)		24.8	А
Single Pulsed (Note 2)	E _{AS}	440	mJ
Repetitive (Note 1)	E _{AR}	13	mJ
Power Dissipation		62.5	W
Junction Temperature		+150	
Operating Temperature		-55 ~ +150	
Storage Temperature		-55 ~ +150	
	$\frac{6N60-A}{6N60-B}$ $\frac{T_{C} = 25^{\circ}C}{T_{C} = 100^{\circ}C}$ Single Pulsed (Note 2)		$ \begin{array}{c c c c c c c c c c c c c c c c c c c $

■ ABSOLUTE MAXIMUM RATINGS (T_c = 25 , unless otherwise specified)

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT
Junction-to-Ambient	θ _{JA}	62	°C/W
Junction-to-Case	θ _{JC}	2	°C/W

■ ELECTRICAL CHARACTERISTICS (T_J=25 , unless otherwise specified)

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PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage	BVDSS	V _{GS} = 0V, I _D = 250µA	600					
L6N60-B	DVDSS	V _{GS} = 0V, I _D = 250μA	650			V		
Drain-Source Leakage Current	I _{DSS}	V _{DS} = 600V, V _{GS} = 0V			10	μA		
Cate Course Lookage Current Forward		$V_{GS} = 30V, V_{DS} = 0V$			100	nA		
Gate- Source Leakage Current Reverse	I _{GSS}	$V_{GS} = -30V, V_{DS} = 0V$			-100	nA		
Breakdown Voltage Temperature	BVpee/ T	I _D = 250 μA, Referenced to 25°C		0.53		V/		
Coefficient	D • D33/ 11			0.00		•/		
ON CHARACTERISTICS								
Gate Threshold Voltage	V _{GS(TH)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V		
Static Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} = 10V, I _D = 3.1A			1.5	Ω		
DYNAMIC CHARACTERISTICS								
Input Capacitance	CISS			770	1000	рF		
Output Capacitance	Coss	V _{DS} =25V, V _{GS} =0V, f=1.0 MHz		95	120	рF		
Reverse Transfer Capacitance	C _{RSS}			10	13	рF		
SWITCHING CHARACTERISTICS								
Turn-On Delay Time	t _{D(ON)}			20	50	ns		
Turn-On Rise Time	t _R	V_{DD} =300V, I_{D} =6.2A, R_{G} =25 Ω		70	150	ns		
Turn-Off Delay Time	t _{D(OFF)}	(Note 4, 5)		40	90	ns		
Turn-Off Fall Time	t⊧	1		45	100	ns		
Total Gate Charge	Q _G			20	25	nC		
Gate-Source Charge	Q _{GS}	V _{DS} =480V, I _D =6.2A, V _{GS} =10 V		4.9		nC		
Gate-Drain Charge	Q _{GD}	(Note 4, 5)				nC		



L6N60

ELECTRICAL CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS								
Drain-Source Diode Forward Voltage	V_{SD}	V_{GS} = 0 V, I_{S} = 6.2 A			1.4	V		
Maximum Continuous Drain-Source Diode Forward Current	I _S				6.2	А		
Maximum Pulsed Drain-Source Diode Forward Current	I _{SM}				24.8	А		
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, I _S = 6.2 A,		290		ns		
Reverse Recovery Charge	Q _{RR}	dl _F /dt = 100 A/µs (Note 4)		2.35		μC		

Notes: 1. Repetitive Rating : Pulse width limited by T_J

2. L = 16.8mH, I_{AS} = 6A, V_{DD} = 90V, R_G = 25 Ω , Starting T_J = 25°C

3. $I_{SD} \le 6.2A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

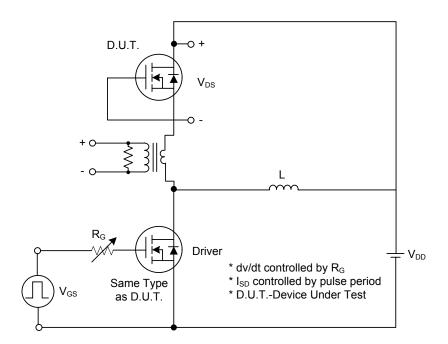
4. Pulse Test: Pulse width \leq 300µs, Duty cycle \leq 2%

5. Essentially independent of operating temperature



TEST CIRCUITS AND WAVEFORMS

L6N60





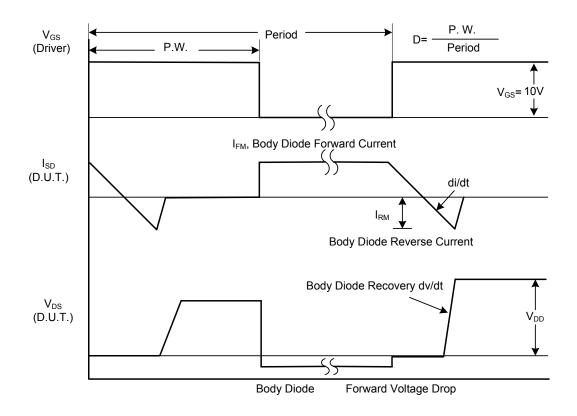


Fig. 1B Peak Diode Recovery dv/dt Waveforms



■ TEST CIRCUITS AND WAVEFORMS (Cont.)

L6N60

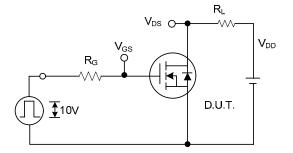


Fig. 2A Switching Test Circuit

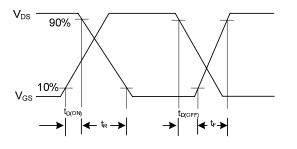


Fig. 2B Switching Waveforms

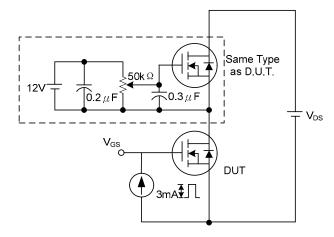
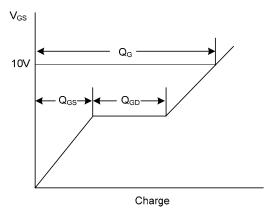
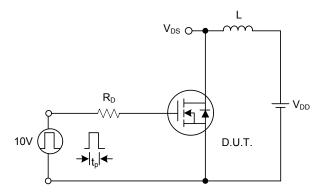


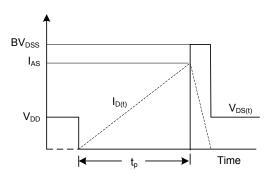
Fig. 3A Gate Charge Test Circuit











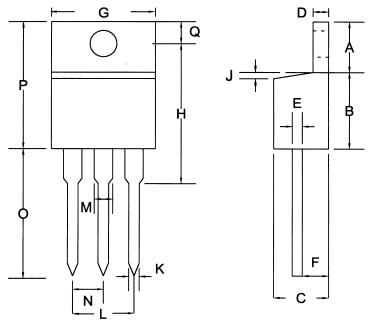






L6N60

TO-220



Ormhal	Dimensions In Millmeters			Dimensions In Inches		
Symbol	Min	Nom	Max	Min	Nom	Max
A	5.58	6.54	7.49	0.220	0.257	0.295
В	8.38	8.64	8.90	0.330	0.340	0.350
С	4.07	4.45	4.82	0.160	0.175	0.190
D	1.15	1.27	1.39	0.045	0.050	0.055
E	0.35	0.45	0.60	0.014	0.018	0.024
F	2.04	2.42	2.79	0.080	0.095	0.110
G	9.66	9.97	10.28	0.380	0.393	0.405
Н		16.25			0.640	
1	3.68	3.83	3.98	0.145	0.151	0.157
J			1.27			0.050
K	0.75	0.85	0.95	0.030	0.033	0.037
L	4.83	5.08	5.33	0.190	0.200	0.210
M	1.15	1.33	1.52	0.045	0.052	0.060
N	2.42	2.54	2.66	0.095	0.100	0.105
0	12.70	13.48	14.27	0.500	0.531	0.562
Р	14.48	15.17	15.87	0.570	0.597	0.625
Q	2.54	2.79	3.04	0.100	0.110	0.120